

<b>Notice of References Cited</b>	Application/Control No. 10/822,522	Applicant(s)/Patent Under Reexamination HSHIEH ET AL.	
	Examiner Charles R. Kasenge	Art Unit 2125	Page 1 of 1

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*	B	US-2005/0086120	04-2005	Shao-Chi et al.	705/026
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**NON-PATENT DOCUMENTS**

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